


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 203348US0CONT		SERIAL NO. NEW U.S. APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yusuke AMINO et al			
				FILING DATE HEREWITH		GROUP 1624	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>W</i>	AA	5,480,668	01/02/96	NOFRE ET AL			<div style="writing-mode: vertical-rl; transform: rotate(180deg);"> J1000 U.S. PRO 09/809197 03/16/01 </div> 
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>W</i>	AO	8-503206	04/08/96	JAPAN			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	WO99/52937 (Abstract)					
	AX						
	AY						
	AZ						
Examiner <i>San</i>					Date Considered 17/29/02		

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
203348US0 CONTSERIAL NO.
09/809,197

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Yusuke AMINO et al.FILING DATE
March 116, 2001GROUP
1624

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
AA	5,968,581	10/19/99	NAKAMURA et al.			
AB						
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FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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